Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/660,628	HARAGUCHI ET AL.	
Examiner	Art Unit	
Tu T. Nguyen	2877	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEAR))
,	DATE	EXMR
EAST	6/21/2006	TN
356/432>440 204/421>429 205/781,784.5,788	6/21/2006	TN